

Efficient DC Voltage Conversion Without Switching

A Path to Extremely Compact and Low Noise DC Voltage Regulators

Matthew Lumb, Founder

Polaris Background

- Founded late 2018 based in Northern
 Virginia
- Fabless semiconductor startup
- Pre-revenue funding via various nondilutive grants
- About me: Spent 10 years in
 Optoelectronics and Radiation Effects
 Branch at NRL



 Optoelectronics and semiconductor device specialist





 $\Lambda F W \equiv R \times$



Introduction

DC Voltage Regulator

- Converts unregulated DC input to regulated
 DC output
- Powers a wide range of digital & analog loads

Requirements for Defense/Space:

- Low noise minimize electromagnetic interference (EMI)
- SWaP minimize footprint and mass
- Efficient minimize heating and maximize battery life
- Radiation hard able to endure harsh space radiation environment





Voltage regulators

Polaris Technology

Switching Regulator

Advantages

- Boost and buck voltage
- ✓ High efficiency

Pains

- × Generates EMI
- × Large footprint and component count

Linear Regulator

- Advantages
- 🖌 No EMI
- Very compact

Pains

- × Buck voltage only
- × Inefficient for large voltage steps

Polaris Semiconductor Technology

- Linear regulator with functionality of a switching regulator
- Boost & buck voltage, no EMI, very compact, high efficiency (65-85%)

How it Works

Standard Linear Regulator

 Controlled voltage drop across pass transistor

Polaris Semiconductor Regulator

Uses photons to raise or lower voltage



High Efficiency

- A problem: typical optocoupler is 1-2% efficient
- Three main losses:
 - Undirected emission
 - Reflection and escape cone losses
 - Spectral mismatch of LED and PV





High Efficiency

PV Output Optocoupler Device

- A problem: typical optocoupler is 1-2% efficient
- Three main losses:
 - Undirected emission
 - Reflection and escape cone losses
 - Spectral mismatch of LED and PV
- Our solution: novel GaAs-based monolithic optocoupler device
- Manufacture identical to GaAs LEDs, VCSELs etc.



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Optocoupler Performance

- Peak efficiency of optocoupler is 52%
- Close to 80% current transfer at high forward bias
- Future efficiency improvements, clear path to 60%





Rseries Optocoupler efficiency (%) SRH 50 45 Experiment 40 Model 35 $Eff=P_{out,PV}/P_{in,LED}$ 30 -20 0 20 40 60 80 100 120 I_{LED} (mA)

SOIC-8 packages 52% optocoupler efficiency (NSF Phase I data) Path to >60%

Non-rad-hard prototypes

- Built a range of proof-of-concept chips, some packaged, some at breadboard level
- Possibility for bypass operation
- Can also achieve galvanic isolation

Voltage in / Voltage out	Polaris regulator efficiency	Linear regulator efficiency	Relative improvement
3.3V/5V (boost)	67%	N/A	N/A
4V/2.5V	77%	66%	17%
3.3V/1.8V	74%	53%	40%
5V/1.8V	66%	36%	80%



Performance - 2.5V buck

- Texas Instruments TPS71525 LDO co-packaged with optocouplers
- TPS71525: 50mA, 2.5V fixed output LDO
- Co-packaged with optocouplers in 7mm QFN32 plastic packages
- Not optimized for size!

MLOC devices

QFN32 package

50mA, 2.5V LDO die





Comparison - 2.5V buck

- Comparison of standard TPS71525 to Polaris device at V_{IN} = 5V, V_{OUT}=2.5V
- Comparable load regulation within datasheet specs of 440 mV/A
- Lower input current for Polaris device optocoupler effect
- ~20% rel. higher efficiency at V_{IN}=5V efficiency advantage increases for larger V_{IN}/V_{OUT} ratios



Transient Response -2.5V buck

- Load step measurements of 2.5V buck regulator containing TPS71525
- Compared to TPS71525 LDO
- Virtually identical load step response!
- SPICE simulation of PSRR slightly lower PSSR at high frequency with optocouplers
- Presently arranging testing of PSSR



Rad-hard Prototypes

- RF Micropower supplied LDOs, I_{out} < 300mA
- Two configurations 5V/1.8V buck, 3.3V/5V boost
- No external caps required





Fig. 1. Schematic cross-section of the SOI MESFET. The Schottky gate of the MESFET is formed using the silicide step that creates the low resistance source drain contacts. Spacer regions of length L_{aS} and L_{aD} are used to isolate the gate silicide from the source/drain silicides. For the MESFET used as the output pass transistor of the linear regulator $L_g = L_{aS} = L_{aD} = 200$ nm, $W_g = 152.2$ nm and the device had a soft breakdown voltage of >5V.

T. Thornton *et al.*, 2013 IEEE Radiation Effects Data Workshop (REDW), July 2013

Device data

- TID irradiation using cobalt-60, up to 1 Mrad(Si) (50, 100, 300, 500, 1000 krad)
- Slight degradation in efficiency, but very little change in either device
- Optocouplers sensitive to displacement damage rad hard optocouplers under development





Present activities

- New program to develop next gen optocouplers
 - Lower R_{series}
 - Improved quantum efficiency
 - High radiation tolerance
- Develop advanced packaging 2.5D and 3D schemes to reduce footprint, Hi-rel packages
- Able to provide prototypes for evaluation or custom builds for particular specs

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Thank you

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